

Notice of References Cited	Application/Control No. 10/635,969	Applicant(s)/Patent Under Reexamination KIM ET AL.	
	Examiner Thao P. Le	Art Unit 2818	Page 1 of 1

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	B	US-6,316,316	11-2001	Wu, Shye-Lin	438/260
	C	US-6,117,756	09-2000	Wu, Shye-Lin	438/594
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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